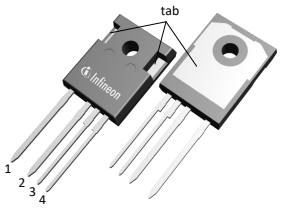
MOSFET

PG-TO247-4

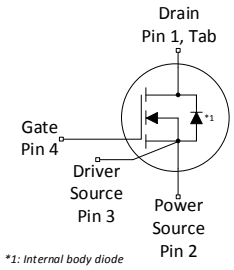


600V CoolMOS™ CM8 Power Transistor

Built on Infineon's world-class super-junction MOSFET platform with an integrated fast body diode, making it suitable for a wide range of applications. It enables highest power density at lowest possible system cost with superior reliability. It is enhancing Infineon's WBG offering and the successor of the 600 V CoolMOS™ 7 MOSFET family.

Features

- Best-In-Class SJ Mosfet Performance
- Address broad hard and soft switching applications with outstanding commutation ruggedness
- Integrated fast body diode and ESD protection
- .XT interconnection technology for best-in-class thermal performance



Benefits

- Provides the best price performance ratio with Best-In-Class SJ Mosfet Performance
- Ease of use and shorter design in cycle
- Enable multiple topologies
- 14-42% lower R_{th} for improved thermal performance

Potential applications

- Datacenter, AI server, Telecom Power Supply
- Micro and Residential Hybrid Inverter
- Portable and Residential Energy Storage, UPS
- EV Charging, Light electric vehicles, Electric Forklift
- High Voltage Solid State Power Distribution
- Home & Professional Tools

Product validation

Fully qualified according to JEDEC for Industrial Applications

Please note: For MOSFET paralleling the use of ferrite beads on the gate or separate totem poles is generally recommended.

Table 1 Key performance parameters

Parameter	Value	Unit
V_{DS} @ $T_{j,max}$	650	V
$R_{DS(on),max}$	99	mΩ
$Q_{g,typ}$	31	nC
$I_{D,pulse}$	87	A
E_{oss} @ 400V	4.2	µJ
Body diode di_F/dt	1300	A/µs
ESD class (HBM)	2	

Part number	Package	Marking	Related links
IPZA60R099CM8	PG-TO247-4	60R099C8	see Appendix A

Table of contents

1 Maximum ratings

at T_j = 25°C, unless otherwise specified

Table 2 Maximum ratings

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Continuous drain current [1]	I_D	-	-	29	A	T_C=25°C
Continuous drain current	I_D	-	-	18	A	T_C=100°C
Pulsed drain current [2]	$I_{D,pulse}$	-	-	87	A	T_C=25°C
Avalanche energy, single pulse	E_{AS}	-	-	51	mJ	I_D=2.7A; V_{DD}=50V; see table 10
Avalanche energy, repetitive	E_{AR}			0.26		
Avalanche current, single pulse	I_{AS}	-	-	2.7	A	-
MOSFET dv/dt ruggedness	dv/dt	-	-	120	V/ns	V_{DS}=0...400V
Gate source voltage (static)	V_{GS}	-20	-	20	V	static;
Gate source voltage (dynamic)	V_{GS}	-30	-	30	V	AC (f>1 Hz)
Power dissipation	P_{tot}	-	-	176	W	T_C=25°C
Storage temperature	T_{stg}	-55	-	150	°C	-
Operating junction temperature	T_j					
Extended operating junction temperature	T_j	150	-	175	°C	≤50 h in the application lifetime
Mounting torque	-	-	-	60	Ncm	M3 and M3.5 screws
Continuous diode forward current	I_S	-	-	29	A	T_C=25°C
Diode pulse current [2]	$I_{S,pulse}$			87		
Reverse diode dv/dt [3]	dv/dt	-	-	70	V/ns	V_{DS}=0...400V, I_{SD}≤29A, T_j=25°C see table 8
Maximum diode commutation speed	di_F/dt			1300	A/µs	
Insulation withstand voltage	V_{ISO}	-	-	n.a.	V	V_{rms}, T_C=25°C, t=1min

[1] Limited by $T_{j,max}$.

[2] Pulse width t_p limited by $T_{j,max}$

[3] Identical low side and high side switch with identical R_G

2 Thermal characteristics

Table 3 Thermal characteristics

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case	R_{thJC}	-	-	0.71	K/W	-
Thermal resistance, junction - ambient	R_{thJA}	-	-	62	K/W	leaded
Thermal resistance, junction - ambient for SMD version	R_{thJA}	-	-	-	K/W	-
Soldering temperature, wavesoldering only allowed at leads	T_{sold}	-	-	260	°C	1.6mm (0.063 in.) from case for 10s

3 Electrical characteristics

at T_j=25°C, unless otherwise specified

Table 4 Static characteristics

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Drain-source breakdown voltage	$V_{(BR)DSS}$	600	-	-	V	V_{GS}=0V, I_D=1mA
Gate threshold voltage	$V_{(GS)th}$	3.7	4.2	4.7	V	V_{DS}=V_{GS}, I_D=0.26mA
Zero gate voltage drain current	I_{DSS}	-	-	1	µA	V_{DS}=600V, V_{GS}=0V, T_j=25°C
			35.5	-		V_{DS}=600V, V_{GS}=0V, T_j=150°C
Gate-source leakage current	I_{GSS}	-	-	2	µA	V_{GS}=20V, V_{DS}=0V
Drain-source on-state resistance	$R_{DS(on)}$	-	0.083	0.099	Ω	V_{GS}=10V, I_D=10.1A, T_j=25°C
			0.183	-		V_{GS}=10V, I_D=10.1A, T_j=150°C
Gate resistance	R_G	-	8.9	-	Ω	f=1MHz

Table 5 Dynamic characteristics

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Input capacitance	C_{iss}	-	1330	-	pF	V_{GS}=0V, V_{DS}=400V, f=250kHz
Output capacitance	C_{oss}		18			
Effective output capacitance, energy related [4]	$C_{o(er)}$	-	53	-	pF	V_{GS}=0V, V_{DS}=0...400V
Effective output capacitance, time related [5]	$C_{o(tr)}$	-	533	-	pF	I_D=constant, V_{GS}=0V, V_{DS}=0...400V
Turn-on delay time	$t_{d(on)}$	-	16.2	-	ns	V_{DD}=400V, V_{GS}=13V, I_D=5.1A, R_G=5.3Ω; see table 9
Rise time	t_r		6			
Turn-off delay time	$t_{d(off)}$		90.1			
Fall time	t_f		9.5			

[4] $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 400V

[5] $C_{o(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 400V

Table 6 Gate charge characteristics

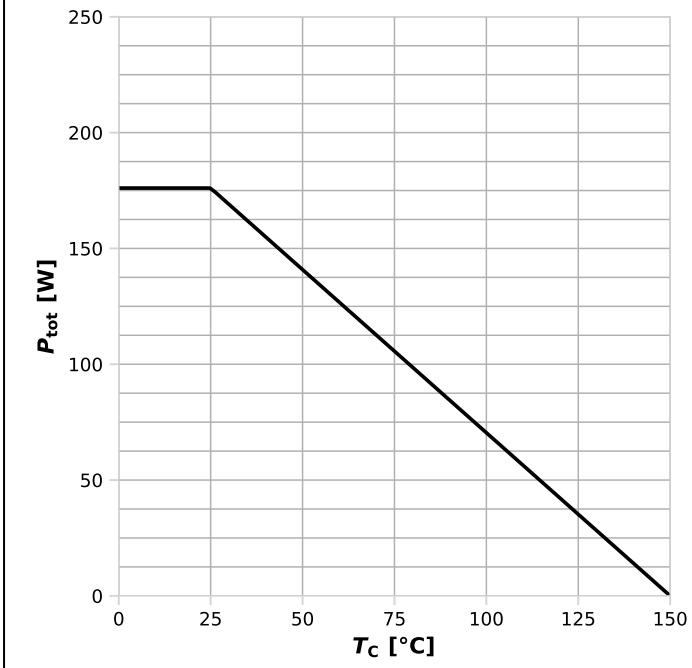
Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Gate to source charge	Q_{gs}	-	8	-	nC	V_{DD}=400V, I_D=5.1A, V_{GS}=0 to 10V
Gate to drain charge	Q_{gd}		11		nC	
Gate charge total	Q_g		31		nC	
Gate plateau voltage	$V_{plateau}$		6.0		V	

Table 7 Reverse diode characteristics

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Diode forward voltage	V_{SD}	-	0.9	-	V	V_{GS}=0V, I_F=5.1A, T_j=25°C
Reverse recovery time	t_{rr}	-	77.3	96.6	ns	V_R=400V, I_F=5.1A, di_F/dt=100A/µs; see table 8
Reverse recovery charge	Q_{rr}		0.30	0.45	µC	
Peak reverse recovery current	I_{rrm}		7.8	-	A	

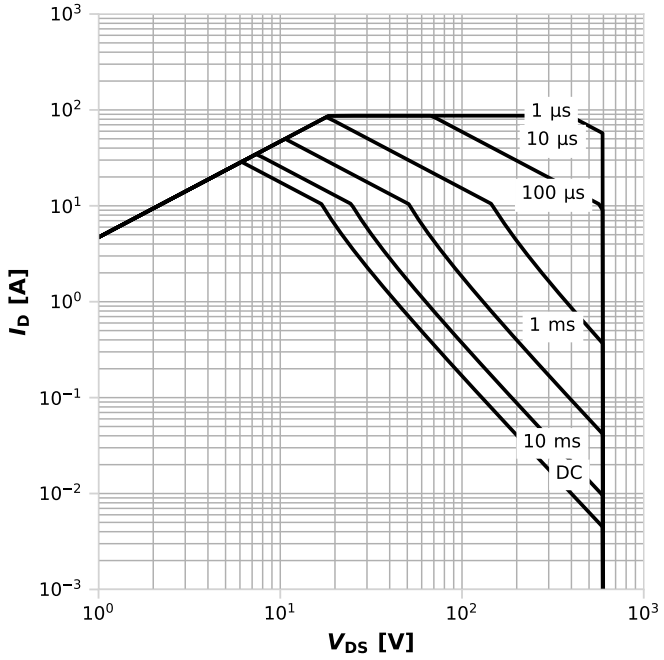
4 Electrical characteristics diagrams

Diagram 1: Power dissipation



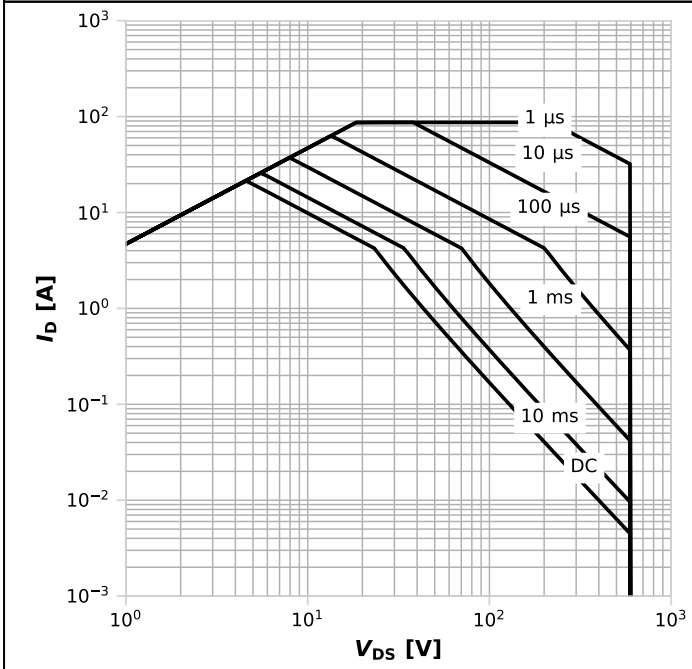
P_{tot}=f(T_C)

Diagram 2: Safe operating area



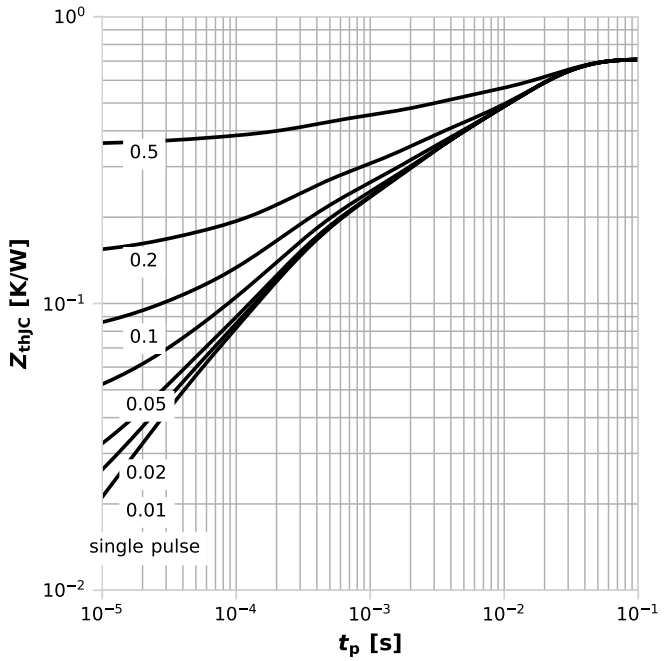
I_D=f(V_{DS}); T_C=25 °C; D=0; parameter: t_p

Diagram 3: Safe operating area



I_D=f(V_{DS}); T_C=80 °C; D=0; parameter: t_p

Diagram 4: Max. transient thermal impedance



Z_{thJC} =f(t_P); parameter: D=t_p/T

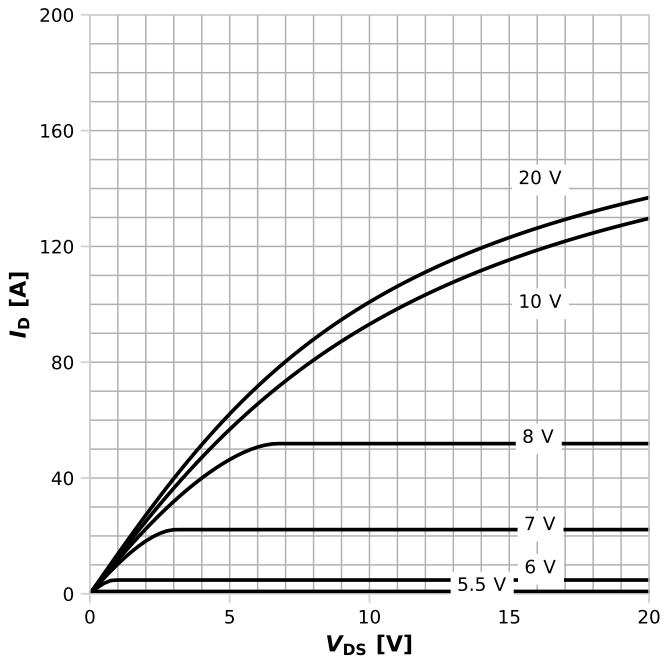
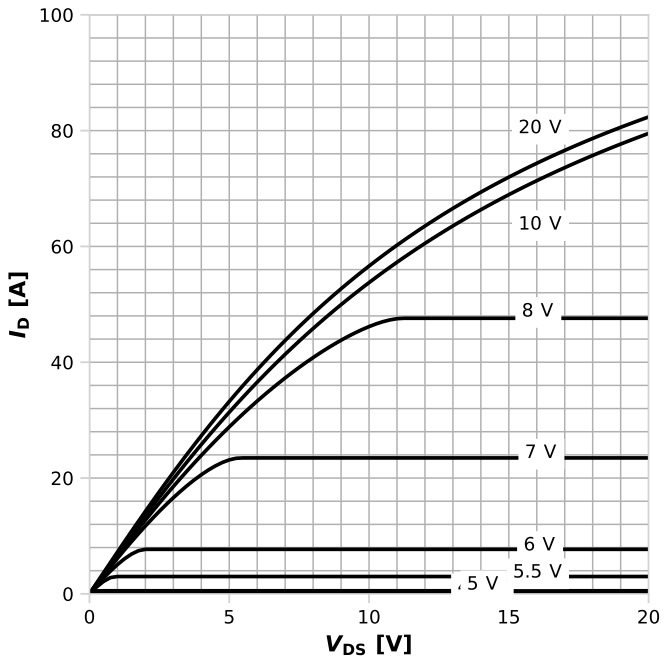
Diagram 5: Typ. output characteristics	Diagram 6: Typ. output characteristics
	
I_D=f(V_{DS}); T_j=25 °C; parameter: V_{GS}	I_D=f(V_{DS}); T_j=125 °C; parameter: V_{GS}

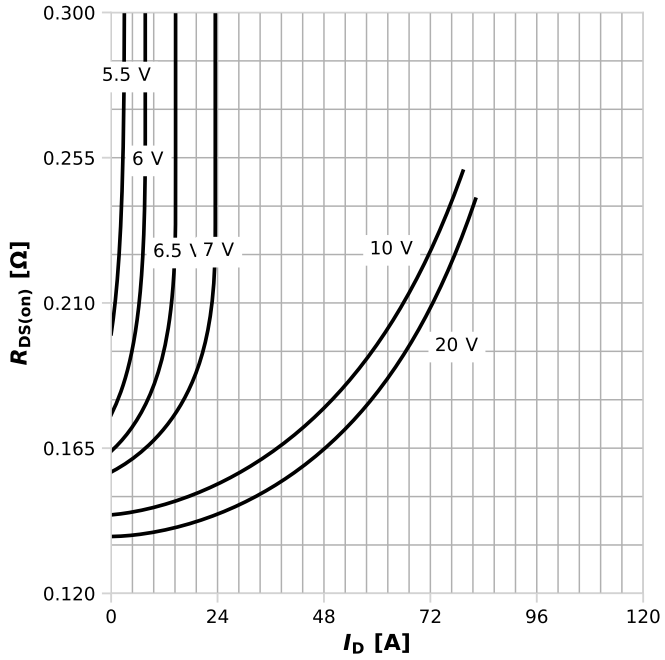
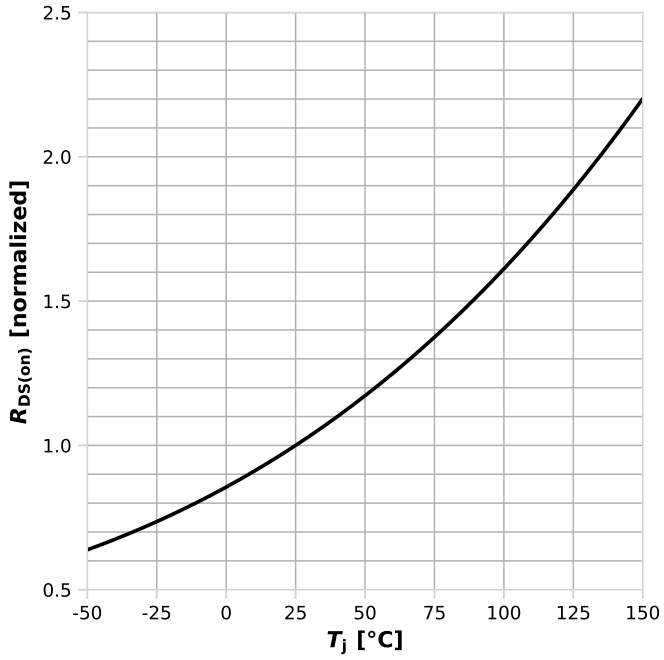
Diagram 7: Typ. drain-source on-state resistance	Diagram 8: Drain-source on-state resistance
	
$R_{DS(on)}$=f(I_D); T_j=125 °C; parameter: V_{GS}	$R_{DS(on)}$=f(T_j); I_D=10.1 A; V_{GS}=10 V

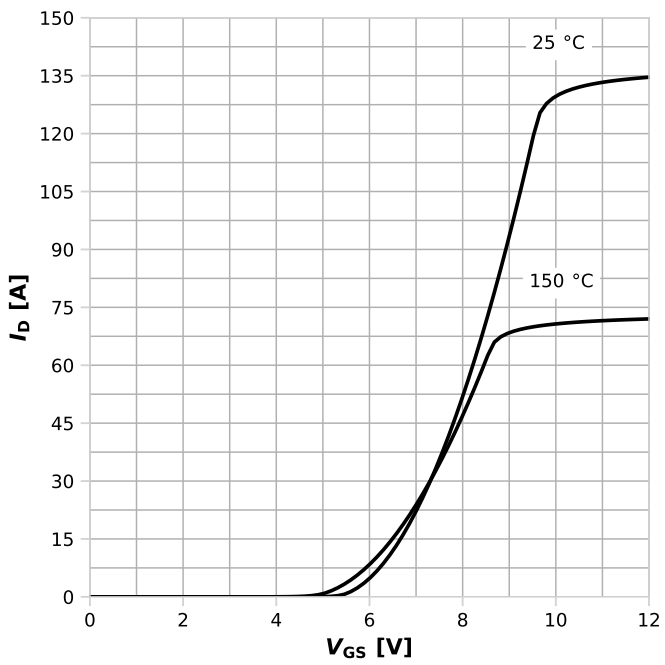
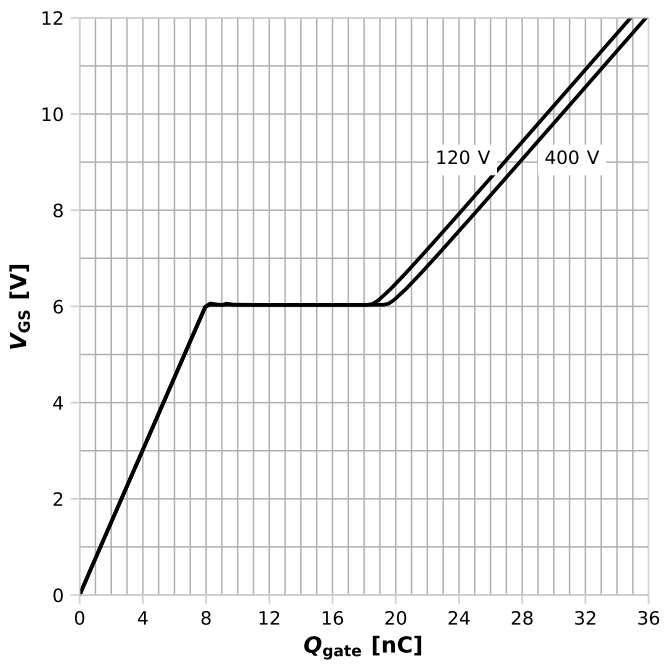
Diagram 9: Typ. transfer characteristics	Diagram 10: Typ. gate charge
	
I_D=f(V_{GS}); V_{DS}=20V; parameter: T_j	V_{GS}=f(Q_{gate}); I_D=5.1 A pulsed; parameter: V_{DD}

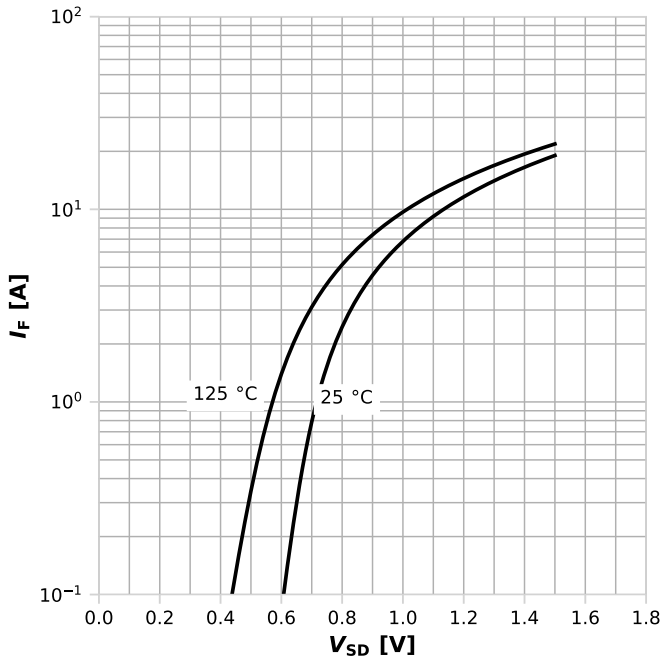
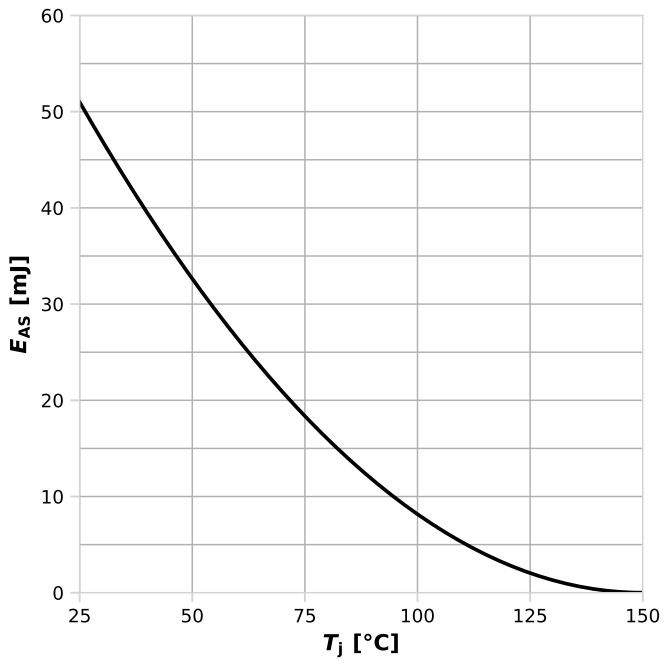
Diagram 11: Forward characteristics of reverse diode	Diagram 12: Avalanche energy
	
I_F=f(V_{SD}); parameter: T_j	E_{AS}=f(T_j); I_D=2.7 A; V_{DD}=50 V

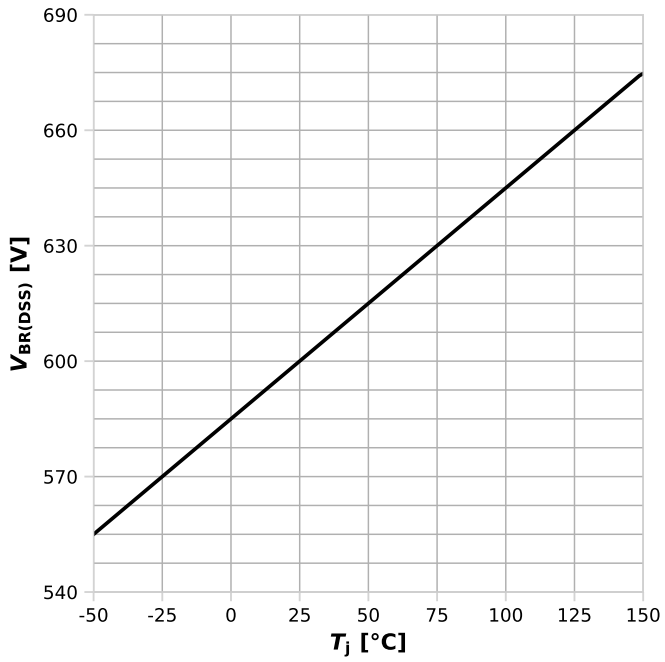
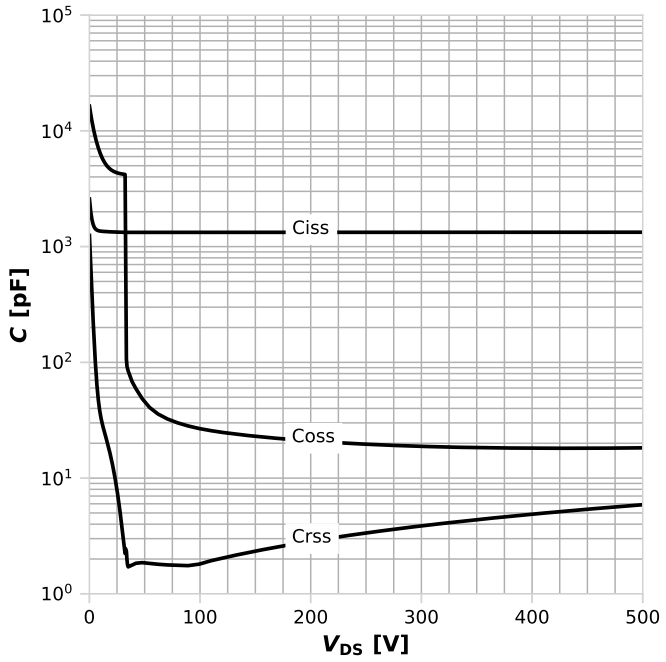
Diagram 13: Drain-source breakdown voltage	Diagram 14: Typ. capacitances
	
$V_{BR(DSS)}$=f(T_j); I_D=1 mA	C=f(V_{DS}); V_{GS}=0 V; f=250 kHz

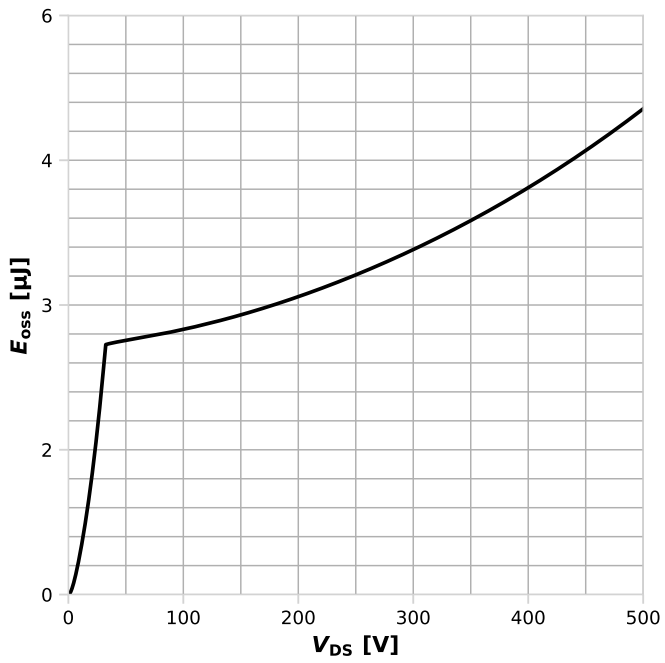
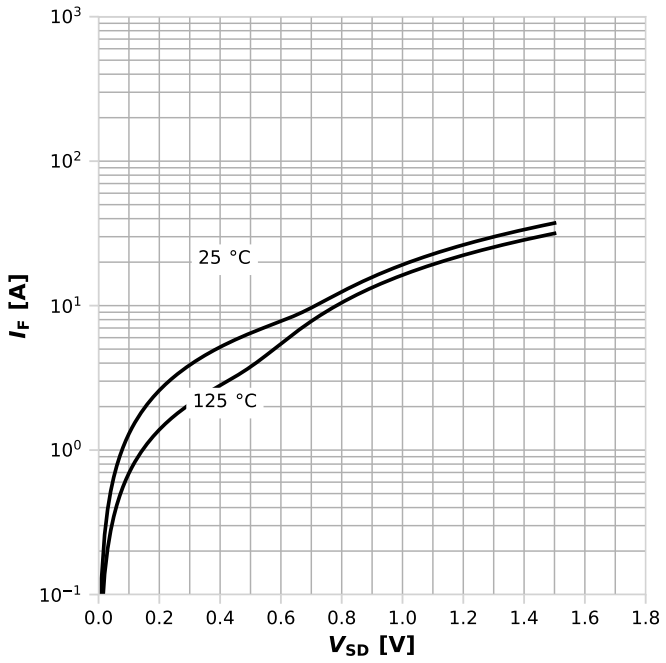
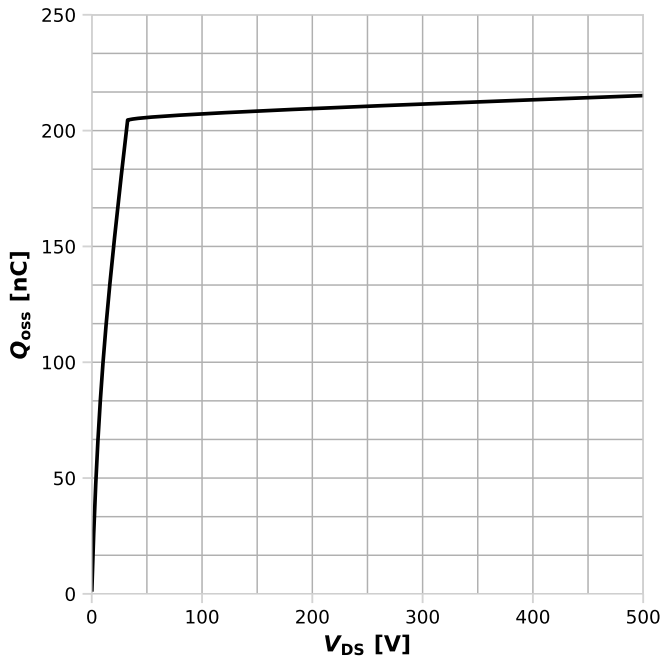
Diagram 15: Typ. Coss stored energy	Diagram 16: Forward characteristics of reverse diode
	
E_{oss}=f(V_{DS})	I_F=f(V_{SD}); V_{GS}=10 V; parameter: T_j

Diagram 17: Typ. Qoss output charge



$Q_{oss}=f(V_{DS})$

5 Test circuits

Table 8 Diode characteristics

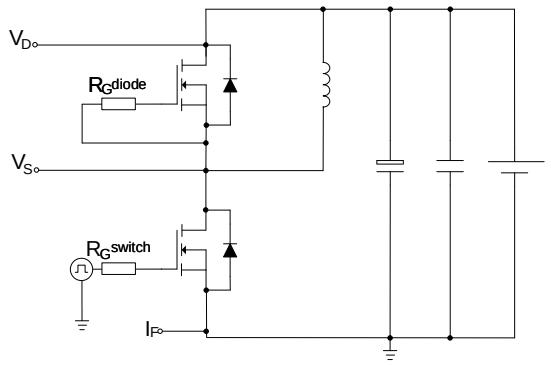
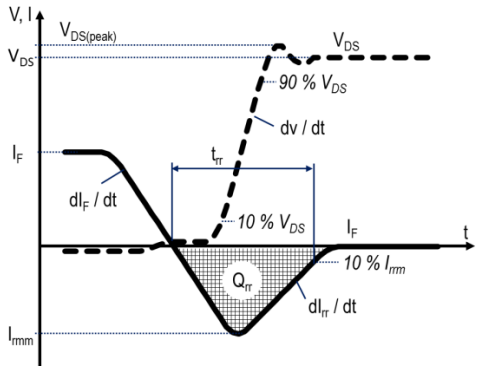
Test circuit for diode characteristics	Diode recovery waveform
	

Table 9 Switching times

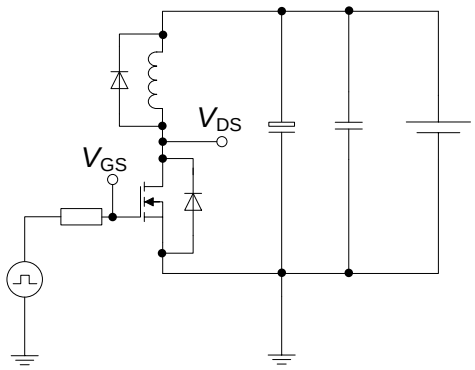
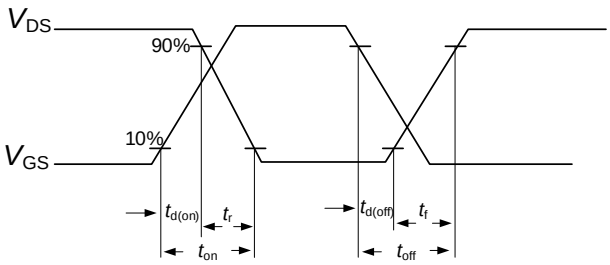
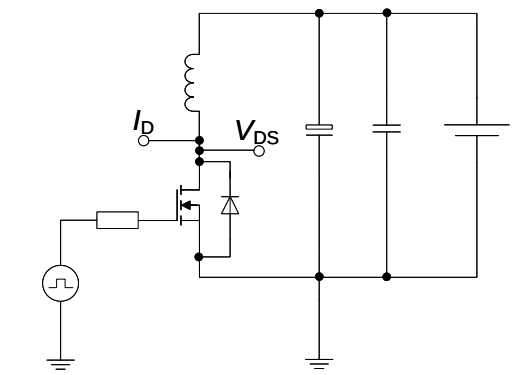
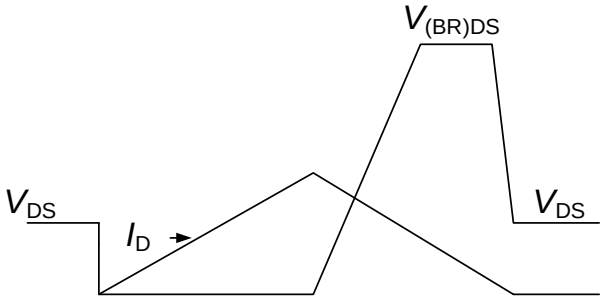
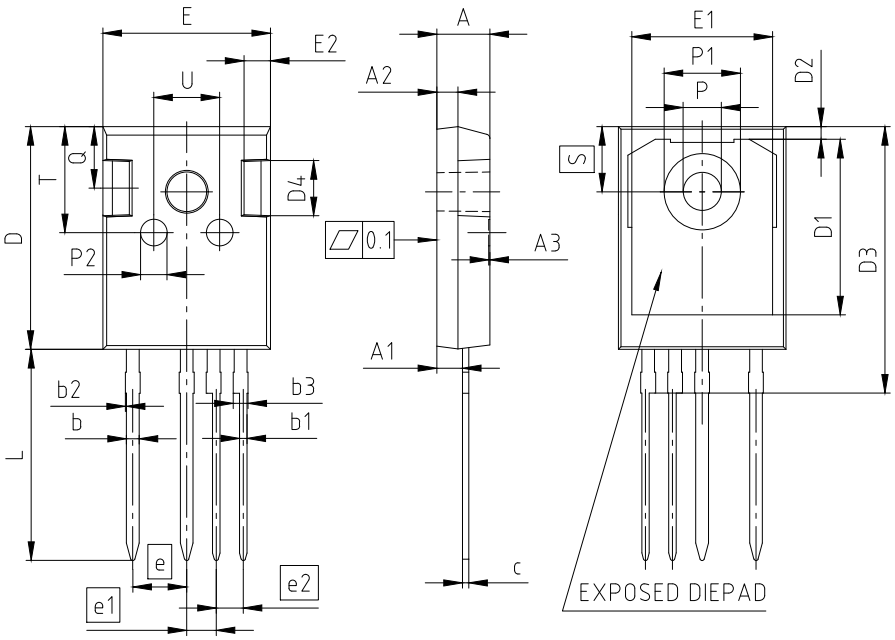
Switching times test circuit for inductive load	Switching times waveform
	

Table 10 Unclamped inductive load

Unclamped inductive load test circuit	Unclamped inductive waveform
	

6 Package outlines



NOTES:
DIMENSIONS DO NOT INCLUDE MOLD FLASH, PROTRUSION OR GATE BURRS

PACKAGE - GROUP NUMBER:	PG-TO247-4-U02				
DIMENSIONS	MILLIMETERS		DIMENSIONS	MILLIMETERS	
	MIN.	MAX.		MIN.	MAX.
A	4.90	5.10	E	15.70	15.90
A1	2.31	2.51	E1	13.10	13.50
A2	1.90	2.10	E2	2.40	2.60
A3	0.05	0.25	e	5.08	
b	1.10	1.30	e1	2.79	
b1	0.65	0.79	e2	2.54	
b2	---	0.20	N	4	
b3	1.34	1.44	L	19.80	20.10
c	0.58	0.66	øP	3.50	3.70
D	20.90	21.10	øP1	7.00	7.40
D1	16.25	16.85	øP2	2.40	2.60
D2	1.05	1.35	Q	5.60	6.00
D3	24.97	25.27	S	6.15	
D4	4.90	5.10	T	9.80	10.20
			U	6.00	6.40

Figure 1 Outline PG-TO247-4, dimensions in mm

7 Appendix A

Table 11 Related links

- IFX CoolMOS CM8 Webpage
- IFX CoolMOS CM8 application note
- IFX CoolMOS CM8 simulation model
- IFX Design tools

Revision history

IPZA60R099CM8

Revision 2025-03-20, Rev. 2.2

Previous revisions

Revision	Date	Subjects (major changes since last revision)
2.0	2024-10-30	Change of SOA diagram scaling
2.1	2025-01-14	Added ESD Classification
2.2	2025-03-20	Update of maximum transient thermal impedance and SOA

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